

Application/Control No.	Applicant(s)/Patent un Reexamination	Applicant(s)/Patent under Reexamination	
09/471,357	NABESHIMA ET AL.	NABESHIMA ET AL.	
Examiner	Art Unit		
Vincent F. Boccio	2621		

			
	SEAR	CHED	
Class	Subclass	Date	Examiner
725	134,37	1/2/06	wer
725	110,109	Ś	7
386	83		
			<u> </u>
348	460,461		
348 Upd.	460,461	3/17/07	m
		•	
		_	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
KAS+ (ATTachel)	7/7/06	ns	
· · · · · · · · · · · · · · · · · · ·			
•			